

# RADIO TEST REPORT

## Test Report No. 15430541S-A-R2

Customer	AISIN CORPORATION
Description of EUT	UWB/NFC Module
Model Number of EUT	AD10
FCC ID	PENAD10
Test Regulation	FCC Part 15 Subpart C
Test Result	Complied
Issue Date	December 5, 2024
Remarks	-

**Representative test engineer**Hiromasa Sato  
Engineer**Approved by**Toyokazu Imamura  
Engineer

CERTIFICATE 1266.03

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 There is no testing item of "Non-accreditation".

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## **REVISION HISTORY**

### **Original Test Report No. 15430541S-A**

This report is a revised version of 15430541S-A-R1. 15430541S-A-R1 is replaced with this report.

Revision	Test Report No.	Date	Page Revised Contents
- (Original)	15430541S-A	September 26, 2024	-
1	15430541S-A-R1	November 11, 2024	P5 Removed description of antenna gain disclaimer from the Radio Specification
2	15430541S-A-R2	December 5, 2024	P5 Modified Test Date: "August 12 to August 13, 2024" → "August 12 to December 5, 2024" P9 Modified typo: "ERECLICAL KEY" → "ELECTRICAL KEY" P18 Replaced data of 20 dB Bandwidth and 99% Occupied Bandwidth P20 Test instruments has been updated to the latest version

## Reference: Abbreviations (Including words undescribed in this report)

A2LA	The American Association for Laboratory Accreditation	ICES	Interference-Causing Equipment Standard
AC	Alternating Current	IEC	International Electrotechnical Commission
AFH	Adaptive Frequency Hopping	IEEE	Institute of Electrical and Electronics Engineers
AM	Amplitude Modulation	IF	Intermediate Frequency
Amp, AMP	Amplifier	ILAC	International Laboratory Accreditation Conference
ANSI	American National Standards Institute	ISED	Innovation, Science and Economic Development Canada
Ant, ANT	Antenna	ISO	International Organization for Standardization
AP	Access Point	JAB	Japan Accreditation Board
ASK	Amplitude Shift Keying	LAN	Local Area Network
Atten., ATT	Attenuator	LIMS	Laboratory Information Management System
AV	Average	MCS	Modulation and Coding Scheme
BPSK	Binary Phase-Shift Keying	MRA	Mutual Recognition Arrangement
BR	Bluetooth Basic Rate	N/A	Not Applicable
BT	Bluetooth	NIST	National Institute of Standards and Technology
BT LE	Bluetooth Low Energy	NS	No signal detect.
BW	BandWidth	NSA	Normalized Site Attenuation
Cal Int	Calibration Interval	NVLAP	National Voluntary Laboratory Accreditation Program
CCK	Complementary Code Keying	OBW	Occupied Band Width
Ch., CH	Channel	OFDM	Orthogonal Frequency Division Multiplexing
CISPR	Comité International Special des Perturbations Radioélectriques	P/M	Power meter
CW	Continuous Wave	PCB	Printed Circuit Board
DBPSK	Differential BPSK	PER	Packet Error Rate
DC	Direct Current	PHY	Physical Layer
D-factor	Distance factor	PK	Peak
DFS	Dynamic Frequency Selection	PN	Pseudo random Noise
DQPSK	Differential QPSK	PRBS	Pseudo-Random Bit Sequence
DSSS	Direct Sequence Spread Spectrum	PSD	Power Spectral Density
EDR	Enhanced Data Rate	QAM	Quadrature Amplitude Modulation
EIRP, e.i.r.p.	Equivalent Isotropically Radiated Power	QP	Quasi-Peak
EMC	ElectroMagnetic Compatibility	QPSK	Quadri-Phase Shift Keying
EMI	ElectroMagnetic Interference	RBW	Resolution Band Width
EN	European Norm	RDS	Radio Data System
ERP, e.r.p.	Effective Radiated Power	RE	Radio Equipment
EU	European Union	RF	Radio Frequency
EUT	Equipment Under Test	RMS	Root Mean Square
Fac.	Factor	RSS	Radio Standards Specifications
FCC	Federal Communications Commission	Rx	Receiving
FHSS	Frequency Hopping Spread Spectrum	SA, S/A	Spectrum Analyzer
FM	Frequency Modulation	SG	Signal Generator
Freq.	Frequency	SVSWR	Site-Voltage Standing Wave Ratio
FSK	Frequency Shift Keying	TR	Test Receiver
GFSK	Gaussian Frequency-Shift Keying	Tx	Transmitting
GNSS	Global Navigation Satellite System	VBW	Video BandWidth
GPS	Global Positioning System	Vert.	Vertical
Hori.	Horizontal	WLAN	Wireless LAN

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## **SECTION 1: Customer Information**

Company Name	AISIN CORPORATION
Address	2-1, Asahi-machi, Kariya, Aichi, 448-8650 JAPAN
Telephone Number	+81-90-6384-0539
Contact Person	Kyosuke Seike

The information provided by the customer is as follows;

- Customer, Description of EUT, Model Number of EUT, FCC ID on the cover and other relevant pages
- Operating/Test Mode(s) (Mode(s)) on all the relevant pages
- SECTION 1: Customer Information
- SECTION 2: Equipment Under Test (EUT) other than the Receipt Date and Test Date
- SECTION 4: Operation of EUT during testing

## **SECTION 2: Equipment Under Test (EUT)**

### **2.1 Identification of EUT**

Description	UWB/NFC Module
Model Number	AD10
Serial Number	Refer to SECTION 4.2
Condition	Production prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification	No Modification by the test lab
Receipt Date	August 2, 2024
Test Date	August 12 to December 5, 2024

### **2.2 Product Description**

#### **General Specification**

Rating	DC 7.1 V (DC 6.0 V to 8.2 V)
Operating Temperature	-40 deg. C to +85 deg. C

#### **Radio Specification**

##### **NFC**

Equipment Type	Transceiver
Frequency of Operation	13.56 MHz
Type of Modulation	ASK (NFC-A)

##### **UWB**

Equipment Type	Transceiver
Frequency of Operation	6489.6 MHz (6240 MHz to 6739.2 MHz) (CH5), 7987.2 MHz (7737.6 MHz to 8236.8 MHz) (CH9)
Type of Modulation	BPM-BPSK
Antenna Gain	3.58 dBi (max)

## **SECTION 3: Test specification, procedures & results**

### **3.1 Test Specification**

Test Specification	FCC Part 15 Subpart C The latest version on the first day of the testing period
Title	FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators Section 15.207 Conducted limits Section 15.225 Operation within the band 13.110-14.010 MHz.

### **3.2 Procedures and results**

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section 15.207	N/A *1)	N/A	-
	<ISED> RSS-Gen 8.8	<ISED> RSS-Gen 8.8			
Electric Field Strength of Fundamental Emission	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section 15.225(a)	57.0 dB, 13.560 MHz, Vertical, QP, 0 deg.	Complied	Radiated
	<ISED> RSS-Gen 6.4, 6.12	<ISED> RSS-210 B.6			
Spectrum Mask	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section 15.225(b)(c)	37.9 dB, 13.553 MHz, Vertical, QP, 0 deg.	Complied	Radiated
	<ISED> RSS-Gen 6.4, 6.13	<ISED> RSS-210 B.6			
20 dB Bandwidth	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section15.215(c)	See data	Complied	Radiated
	<ISED> -	<ISED> -			
Electric Field Strength of Spurious Emission	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section 15.209, Section 15.225 (d)	9.6 dB, 840.72 MHz, Vertical, QP	Complied	Radiated
	<ISED> RSS-Gen 6.4, 6.13	<ISED> RSS-210 B.6 RSS-Gen 8.9			
Frequency Tolerance	<FCC> ANSI C63.10:2013 6 Standard test methods	<FCC> Section 15.225(e)	See data	Complied	Radiated
	<ISED> RSS-Gen 6.11, 8.11	<ISED> RSS-210 B.6			

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

\*1) The test was not performed since the EUT was DC device.

#### **FCC Part 15.31 (e)**

The stable voltage was supplied by the end product which was required to have a power supply regulator. Therefore, the EUT complies with the requirement.

However, the supply voltage was varied and tested at 85 % and 115 % of the nominal rated supply voltage during frequency tolerance test according to Section 15.225(e).

#### **FCC Part 15.203 Antenna requirement**

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

### 3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % emission bandwidth	<ISED>RSS-Gen 6.7	-	N/A	-	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures: Work Instructions-ULID-003591 and Work Instructions-ULID-003593.

Other than above, no addition, exclusion nor deviation has been made from the standard.

### 3.4 Uncertainty

Measurement uncertainty is not taken into account when stating conformity with a specified requirement.  
Note: When margins obtained from test results are less than the measurement uncertainty, the test results may exceed the limit.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor  $k = 2$ .

Item	Frequency range	Uncertainty (+/-)
Conducted Emission (AC Mains) LISN	150 kHz to 30 MHz	3.2 dB
Radiated Emission (Measurement distance: 3 m)	9 kHz to 30 MHz	3.3 dB
	30 MHz to 200 MHz	4.9 dB
	200 MHz to 1 GHz	6.2 dB
	1 GHz to 6 GHz	4.7 dB
	6 GHz to 18 GHz	5.3 dB
	18 GHz to 40 GHz	5.5 dB

Other test	Uncertainty (+/-)
Frequency Measurement (13.56 MHz)	$1.7 \times 10^{-7}$
Bandwidth Measurement	0.012 %
Temperature	0.96 deg.C.
Humidity	4.0 %
Voltage	0.74 %

### 3.5 Test Location

UL Japan, Inc. Shonan EMC Lab.  
1-22-3, Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN  
Telephone: +81-463-50-6400  
A2LA Certificate Number: 1266.03

Test room	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
No.1 Semi-anechoic chamber (SAC1)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.2 Semi-anechoic chamber (SAC2)	20.6 x 11.3 x 7.65	20.6 x 11.3	10 m
No.3 Semi-anechoic chamber (SAC3)	12.7 x 7.7 x 5.35	12.7 x 7.7	5 m
No.4 Semi-anechoic chamber (SAC4)	8.1 x 5.1 x 3.55	8.1 x 5.1	-
Wireless anechoic chamber 1 (WAC1)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
Wireless anechoic chamber 2 (WAC2)	9.5 x 6.0 x 5.4	9.5 x 6.0	3 m
No.1 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.2 Shielded room	6.8 x 4.1 x 2.7	6.8 x 4.1	-
No.3 Shielded room	6.3 x 4.7 x 2.7	6.3 x 4.7	-
No.4 Shielded room	4.4 x 4.7 x 2.7	4.4 x 4.7	-
No.5 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.6 Shielded room	7.8 x 6.4 x 2.7	7.8 x 6.4	-
No.8 Shielded room	3.45 x 5.5 x 2.4	3.45 x 5.5	-
No.1 Measurement room	2.55 x 4.1 x 2.5	-	-
No.2 Measurement room	4.5 x 3.5 x 2.5	-	-
Wireless shielded room 1	3.0 x 4.5 x 2.7	3.0 x 4.5	-
Wireless shielded room 2	3.0 x 4.5 x 2.7	3.0 x 4.5	-

### 3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

## **SECTION 4: Operation of EUT during testing**

### **4.1 Operating Mode(s)**

The mode is used:

Test mode	Remarks
1) Transmitting mode (Tx) (13.56 MHz)	The EUT Transmits and Receives at the same time and there is no receiving mode.

The EUT was operated in a manner similar to typical use during the tests.

\*Power of the EUT was set by the software as follows;

Software: SOFTWARE, ELECTRICAL KEY, B Version: 00001  
(Date: 2024.07.12, Storage location: EUT memory)

\*This setting of software is the worst case.

Any conditions under the normal use do not exceed the condition of setting.

In addition, end users cannot change the settings of the output power of the product.

Justification: The system was configured in typical fashion (as a user would normally use it) for testing.

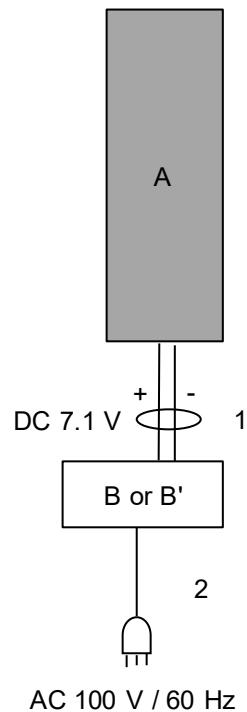
Test Item	Operating mode*
Electric Field Strength of Fundamental Emission	Tx, without Tag
Spectrum Mask	Tx, without Tag
20 dB Bandwidth and 99 % Occupied Bandwidth	Tx, with Tag (Pattern 1)
Electric Field Strength of Spurious Emission	Tx, without Tag
Frequency Tolerance	Tx, without Tag

\* After the comparison of the test data between with Tag and without Tag, the tests were performed with the worst case.

Frequency Tolerance	
Temperature	-20 deg. C to +50 deg.C Step 10 deg. C
Voltage	Normal Voltage DC 7.1 V Maximum Voltage DC 6 V (DC 7.1 V +15 %) Minimum Voltage DC 8.2 V (DC 7.1 V -15 %)

\*This EUT provides stable voltage constantly to RF Part regardless of input voltage

## 4.2 Configuration and peripherals



\* Cabling and setup were taken into consideration and test data was taken under worse case conditions.

### Description of EUT and Support Equipment

No.	Item	Model number	Serial Number	Manufacturer	Remark
A	UWB/NFC Module	AD10	SH1DN24171	AISIN	EUT
B	Power Supply (DC)	PAN60-10A	NL002383	KIKUSUI	*1)
B'	Power Supply (DC)	PAN35-10A	NA000955	KIKUSUI	*2)

\*1) Used for Other Tests

\*2) Used for Radiated Emission Tests

### List of Cables Used

No.	Name	Length (m)	Shield		Remark
			Cable	Connector	
1	DC	1.0	Unshielded	Unshielded	-
2	AC	2.0	Unshielded	Unshielded	-

## **SECTION 5: Radiated Emission (Fundamental, Spurious Emission and Spectrum Mask)**

### **Test Procedure**

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

#### [Limit conversion]

The limits in CFR 47, Part 15, Subpart C, paragraph 15.209(a), are identical to those in RSS-Gen section 8.9, Table 6, since the measurements are performed in terms of magnetic field strength and converted to electric field strength levels (as reported in the table) using the free space impedance of 377 Ohms. For example, the measurement at frequency 9 kHz resulted in a level of 45.5 dBuV/m, which is equivalent to  $45.5 - 51.5 = -6.0$  dBuA/m, which has the same margin, 3 dB, to the corresponding RSS-Gen Table 6 limit as it has to 15.209(a) limit.

#### [Frequency: From 9 kHz to 30 MHz]

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., and 135 deg.) and horizontal polarization.

\*Refer to Figure 2 about Direction of the Loop Antenna.

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane. However test results were confirmed to pass against standard limit.

#### [Frequency: From 30 MHz to 1 GHz]

The measuring antenna height varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

#### [Test instruments and test settings]

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz
Antenna Type	Loop	Biconical	Logperiodic

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

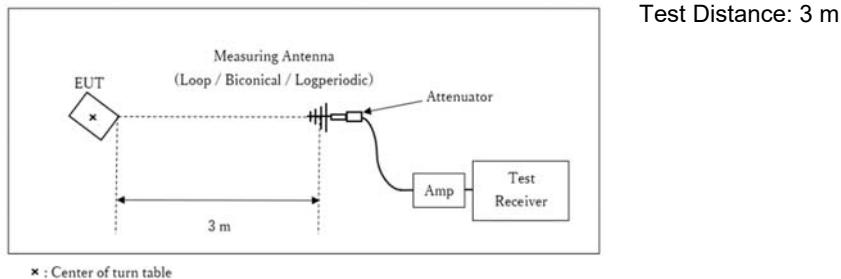
Frequency	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz
Instrument used	Test Receiver				
Detector	PK / AV	QP	PK / AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Test Distance	3 m *1)	3 m *1)	3 m *1)	3 m *2)	3 m

\*1) Distance Factor:  $40 \times \log (3 \text{ m} / 300 \text{ m}) = -80 \text{ dB}$

\*2) Distance Factor:  $40 \times \log (3 \text{ m} / 30 \text{ m}) = -40 \text{ dB}$

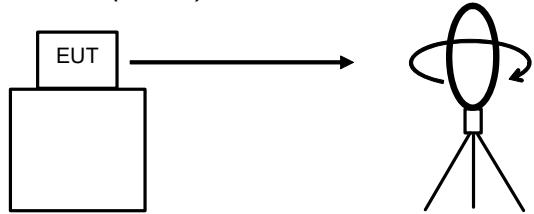
**Figure 1: Test Setup**

Below 1 GHz



**Figure 2: Direction of the Loop Antenna**

*Side View (Vertical)*

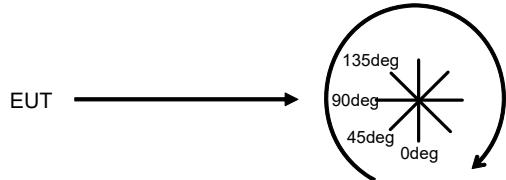


*Top View (Horizontal)*



Antenna was not rotated.

*Top View (Vertical)*



Front side: 0 deg.  
Forward direction: clockwise

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Frequency Test Antenna	Carrier	Below 30 MHz	Above 30 MHz
Horizontal	Z	X	Z
Vertical	Y	X	Z

The test results and limit are rounded off to one decimal place, so some differences might be observed.

**Measurement range** : 9 kHz to 1 GHz  
**Test data** : APPENDIX  
**Test result** : Pass

## SECTION 6: Other tests

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	100 kHz	1 kHz	3 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 kHz	3 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
Frequency Tolerance	-	-	-	-	-	-	Spectrum Analyzer *1)
Peak hold was applied as Worst-case measurement.							
*1) The measurement was performed with Marker Frequency Counter Function.							

**Test data** : APPENDIX  
**Test result** : Pass

## APPENDIX 1: Test data

### Fundamental Emission and Spectrum Mask

Test place Shonan EMC Lab.  
 Semi Anechoic Chamber SAC3  
 Date August 12, 2024  
 Temperature / Humidity 25 deg. C / 49 % RH  
 Engineer Hiromasa Sato  
 Mode Tx, without Tag  
 Remarks Axis: Horizontal Z  
 Vertical Y, Vertical polarization (antenna angle) of the worst case: 0 deg.

#### Fundamental emission

No.	FREQ [MHz]	Test Receiver Reading		Antenna Factor [dB/m]	Loss [dB]	AMP GAIN [dB]	Distance factor [dB]	RESULT		LIMIT (30m) [dBuV/m]	MARGIN	
		Hor [dBuV]	Ver [dBuV]					Hor [dBuV/m]	Ver [dBuV/m]		Hor [dB]	Ver [dB]
1	13.560	62.4	73.3	19.4	6.4	32.2	-40.0	16.0	26.9	83.9	67.9	57.0

Calculation: Result[dBuV/m] = Reading[dBuV] + Ant.Fac[dB/m] + Loss(Cable+ATT)[dB] - Gain(AMP)[dB] + Distance factor[dB]

Distance factor:  $40 \times \log(3 \text{ m}/30 \text{ m}) = -40 \text{ dB}$

Limits (30 m)

• 13.553 MHz to 13.567 MHz : 83.9 dBuV/m (FCC 15.225(a))

#### Spurious emission within the band

No.	FREQ [MHz]	Test Receiver Reading		Antenna Factor [dB/m]	Loss [dB]	AMP GAIN [dB]	Distance factor [dB]	RESULT		LIMIT (30m) [dBuV/m]	MARGIN	
		Hor [dBuV]	Ver [dBuV]					Hor [dBuV/m]	Ver [dBuV/m]		Hor [dB]	Ver [dB]
1	13.110	30.3	30.5	19.5	6.4	32.2	-40.0	-16.1	-15.9	29.5	45.6	45.4
2	13.410	32.0	41.1	19.4	6.4	32.2	-40.0	-14.4	-5.31	40.5	54.9	45.8
3	13.553	48.1	58.9	19.4	6.4	32.2	-40.0	1.7	12.5	50.4	48.7	37.9
4	13.567	47.7	58.4	19.4	6.4	32.2	-40.0	1.3	12.0	50.4	49.1	38.4
5	13.710	32.2	40.7	19.4	6.4	32.2	-40.0	-14.2	-5.66	40.5	54.7	46.2
6	14.010	30.3	30.5	19.4	6.4	32.2	-40.0	-16.0	-15.92	29.5	45.5	45.4

Calculation: Result[dBuV/m] = Reading[dBuV] + Ant.Fac[dB/m] + Loss(Cable+ATT)[dB] - Gain(AMP)[dB] + Distance factor[dB]

Outside filed strength frequencies

- $F_c \pm 7 \text{ kHz}$ : 13.553 MHz to 13.567 MHz
- $F_c \pm 150 \text{ kHz}$ : 13.410 MHz to 13.710 MHz
- $F_c \pm 450 \text{ kHz}$ : 13.110 MHz to 14.010 MHz

$F_c = 13.56 \text{ MHz}$

Limits (30 m)

- 13.410 MHz to 13.553 MHz and 13.567 MHz to 13.710 MHz : 50.4 dBuV/m (FCC 15.225(b))
- 13.110 MHz to 13.410 MHz and 13.710 MHz to 14.010 MHz : 40.5 dBuV/m (FCC 15.225(c))
- Below 13.110 MHz and Above 14.010 MHz : 29.5 dBuV/m (FCC 15.225(d) and FCC 15.209)

## Spurious Emission

Test place Shonan EMC Lab.  
Semi Anechoic Chamber SAC3  
Date August 12, 2024  
Temperature / Humidity 25 deg. C / 49 % RH  
Engineer Hiromasa Sato  
Mode Tx, without Tag  
Below 30 MHz (Horizontal: X-axis, Vertical: X-axis), without Tag  
Above 30 MHz (Horizontal: Z-axis, Vertical: Z-axis), without Tag

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Distance Factor [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg.]	Remark
Hori.	27.12	QP	29.3	20.0	6.7	32.2	-40.0	-16.2	29.5	45.7	-	178	* Limit: 30m
Hori.	135.600	QP	36.0	14.1	7.4	32.1	0.0	25.4	43.5	18.1	100	301	
Hori.	325.440	QP	41.4	13.4	8.6	31.9	0.0	31.5	46.0	14.5	100	27	
Vert.	27.12	QP	29.1	20.0	6.7	32.2	-40.0	-16.4	29.5	45.9	-	356	* Limit: 30m
Vert.	325.440	QP	45.5	13.4	8.6	31.9	0.0	35.6	46.0	10.4	100	25	
Vert.	569.520	QP	36.4	18.0	9.7	31.9	0.0	32.1	46.0	13.9	149	38	
Vert.	596.640	QP	36.6	18.5	9.8	31.9	0.0	33.0	46.0	13.0	148	42	
Vert.	678.000	QP	35.8	20.0	10.1	31.8	0.0	34.1	46.0	11.9	100	61	
Vert.	840.72	QP	35.7	21.4	10.7	31.3	0.0	36.4	46.0	<b>9.6</b>	100	53	
Vert.	867.84	QP	33.8	22.1	10.8	31.2	0.0	35.6	46.0	10.4	100	52	

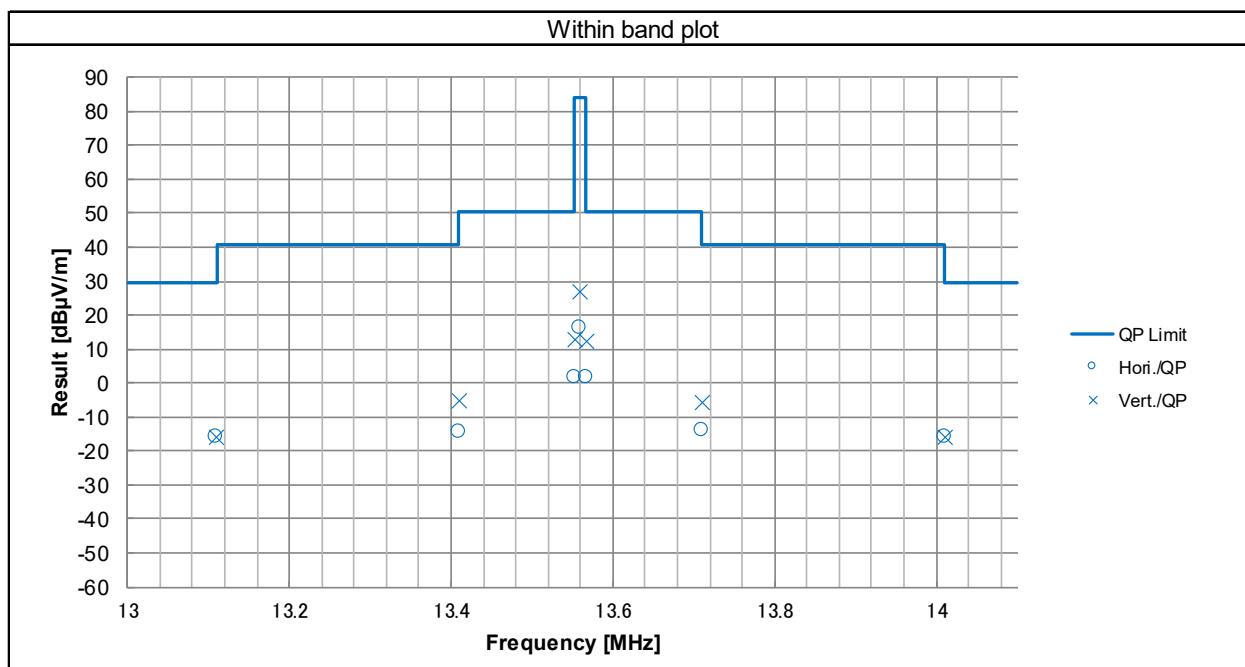
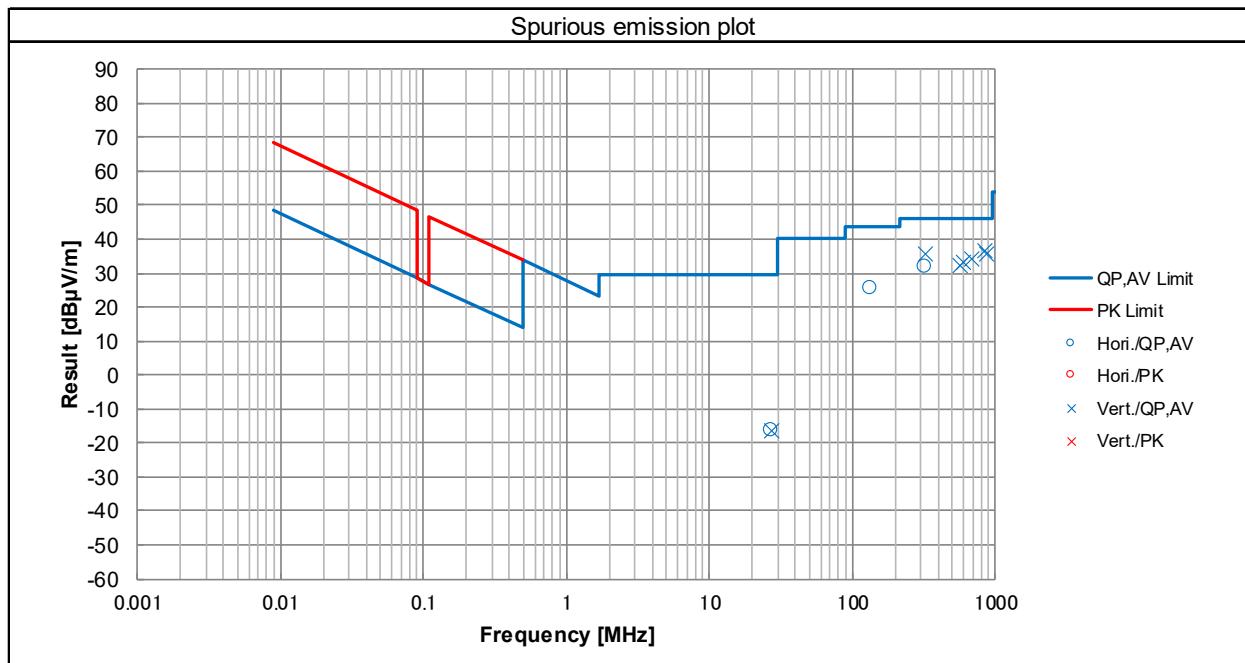
Result = Reading + Ant Factor + Loss (Cable+ATT+ΔAF(above 30 MHz)) - Gain(Amplifier) + Distance factor(below 30 MHz)

\* Other frequency noises omitted in this report were not seen or have enough margin (more than 20 dB).

\* Carrier level (Result at 3 m): Hori= 56 dBuV/m, Ver= 66.9 dBuV/m

**Radiated Spurious Emission**  
**(Plot data, Worst case for Spurious Emission)**

Test place Shonan EMC Lab.  
Semi Anechoic Chamber SAC3  
Date August 12, 2024  
Temperature / Humidity 25 deg. C / 49 % RH  
Engineer Hiromasa Sato  
Mode Tx, without Tag  
Below 30 MHz (Horizontal: X-axis, Vertical: X-axis), without Tag  
Above 30 MHz (Horizontal: Z-axis, Vertical: Z-axis), without Tag

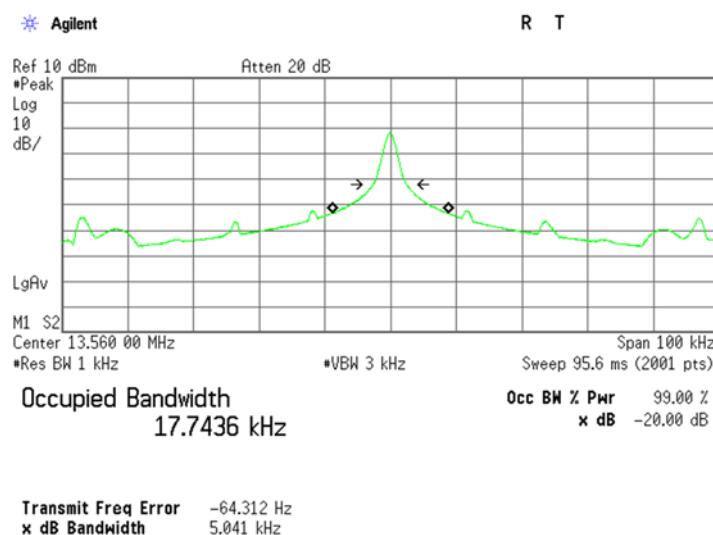


\*These plots data contains sufficient number to show the trend of characteristic features for EUT.

## 20 dB Bandwidth and 99% Occupied Bandwidth

Test place Shonan EMC Lab.  
Shielded Room No.5  
Date December 5, 2024  
Temperature / Humidity 24 deg. C / 50 % RH  
Engineer Hiromasa Sato  
Mode Tx, with Tag

FREQ [MHz]	20dB Bandwidth [kHz]	99% Occupied Bandwidth [kHz]
13.56	5.041	17.7436



Since the transmitter signal is CW-like it is impractical to use a RBW setting of 1 – 5 % of the emission bandwidth since the emission bandwidth will be proportional to the RBW.

## Frequency Tolerance

Test place Shonan EMC Lab.  
Shielded Room No.5  
Date August 13, 2024  
Temperature / Humidity 23 deg. C / 40 % RH  
Engineer Hiromasa Sato  
Mode Tx, without Tag

Temp. [deg. C]	Test condition Voltage [V]	Tested timing	Measured frequency [MHz]	Frequency error [MHz]	Result		Limit [+/- %]
					[%]	[ppm]	
50	7.1	Power on	13.559962	-0.000038	-0.00028	-2.8	0.01
		+ 2 min.	13.559937	-0.000063	-0.00046	-4.6	0.01
		+ 5 min.	13.559881	-0.000119	-0.00088	-8.8	0.01
		+ 10 min.	13.559874	-0.000126	-0.00093	-9.3	0.01
40	7.1	Power on	13.559905	-0.000095	-0.00070	-7.0	0.01
		+ 2 min.	13.559857	-0.000143	-0.00105	-10.5	0.01
		+ 5 min.	13.559813	-0.000187	-0.00138	-13.8	0.01
		+ 10 min.	13.559693	-0.000307	-0.00226	-22.6	0.01
30	7.1	Power on	13.559943	-0.000057	-0.00042	-4.2	0.01
		+ 2 min.	13.559938	-0.000062	-0.00046	-4.6	0.01
		+ 5 min.	13.559939	-0.000061	-0.00045	-4.5	0.01
		+ 10 min.	13.559936	-0.000064	-0.00047	-4.7	0.01
20	7.1	Power on	13.559972	-0.000028	-0.00021	-2.1	0.01
		+ 2 min.	13.559970	-0.000030	-0.00022	-2.2	0.01
		+ 5 min.	13.560006	0.000006	0.00004	0.4	0.01
		+ 10 min.	13.559799	-0.000201	-0.00148	-14.8	0.01
20	6 (7.1V -15%)	Power on	13.560035	0.000035	0.00026	2.6	0.01
		+ 2 min.	13.560060	0.000060	0.00044	4.4	0.01
		+ 5 min.	13.560037	0.000037	0.00027	2.7	0.01
		+ 10 min.	13.559984	-0.000016	-0.00012	-1.2	0.01
20	8.2 (7.1V +15%)	Power on	13.559985	-0.000015	-0.00011	-1.1	0.01
		+ 2 min.	13.559977	-0.000023	-0.00017	-1.7	0.01
		+ 5 min.	13.560216	0.000216	0.00160	16.0	0.01
		+ 10 min.	13.559972	-0.000028	-0.00021	-2.1	0.01
10	7.1	Power on	13.560058	0.000058	0.00043	4.3	0.01
		+ 2 min.	13.560216	0.000216	0.00159	15.9	0.01
		+ 5 min.	13.559981	-0.000019	-0.00014	-1.4	0.01
		+ 10 min.	13.560034	0.000034	0.00025	2.5	0.01
0	7.1	Power on	13.560128	0.000128	0.00094	9.4	0.01
		+ 2 min.	13.560051	0.000051	0.00037	3.7	0.01
		+ 5 min.	13.560215	0.000215	0.00158	15.8	0.01
		+ 10 min.	13.560009	0.000009	0.00007	0.7	0.01
-10	7.1	Power on	13.560084	0.000084	0.00062	6.2	0.01
		+ 2 min.	13.560101	0.000101	0.00075	7.5	0.01
		+ 5 min.	13.560087	0.000087	0.00064	6.4	0.01
		+ 10 min.	13.559925	-0.000075	-0.00056	-5.6	0.01
-20	7.1	Power on	13.560082	0.000082	0.00060	6.0	0.01
		+ 2 min.	13.560004	0.000004	0.00003	0.3	0.01
		+ 5 min.	13.560248	0.000248	0.00183	18.3	0.01
		+ 10 min.	13.560066	0.000066	0.00049	4.9	0.01

Calculation formula:

Frequency error = Measured frequency - Tested frequency

Result [%] = Frequency error / Tested frequency \* 100

Tested frequency:

13.56 MHz

Limit (+/-):

0.01 %      (+/- 100ppm)

\*The test was begun from 50 deg. C and the temperature was lowered each 10 deg. C.

## APPENDIX 2: Test instruments

### Test Equipment

Test Item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Cal Int
BW,FT	145200	Temperature and Humidity Chamber	Espec	PL-1KT	14020837	2024/04/26	12
BW,FT	145800	Spectrum Analyzer	Keysight Technologies Inc	E4448A	MY48250106	2024/03/25	12
BW,FT	146178	Search coil	Langer	RF-R 400-1	02-0634	-	-
BW,FT	146212	Digital Hitester	HIOKI E.E. CORPORATION	3805-50	80997828	2024/09/24	12
BW,FT,RE	191840	Thermo-Hygrometer	CUSTOM. Inc	CTH-201	-	2024/08/12	12
RE	145023	Biconical Antenna	Schwarzbeck Mess-Elektronik OHG	BBA9106	91032666	2024/05/10	12
RE	145126	Pre Amplifier	SONOMA	310N	290213	2024/02/07	12
RE	145171	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner/Suhner/Suhner/TOYO	8D2W/12DSFA/141PE/141PE/141PE/141PE/NS4906	-/0901-271(RF Selector)	2024/04/01	12
RE	145529	Logperiodic Antenna	Schwarzbeck Mess-Elektronik OHG	VUSLP9111B	196	2024/05/10	12
RE	145536	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100218	2024/04/10	12
RE	145565	Semi-Anechoic Chamber	TDK	SAEC-03(NSA)	3	2024/04/03	12
RE	145568	Semi Anechoic Chamber(ME)	TDK	Semi Anechoic Chamber 3m/10m	1, 2, 3	2022/12/24	24
RE	146210	Digital Hitester	HIOKI E.E. CORPORATION	3805-50	80997823	2023/09/25	12
RE	146432	Tape Measure	TAJIMA	GL19-55	-	-	-
RE	167094	Attenuator	JFW	50HF-006N	-	2024/02/13	12
RE	167096	Attenuator	JFW	50HF-006N	-	2024/02/13	12
RE	170932	EMI Software	TSJ (Techno Science Japan)	TEPTO-DV3(RE,CE,ME,PE)	Ver 3.1.0546	-	-
RE	194601	Coaxial Cable	Fjikura	5D-2W	-	2023/12/08	12
RE	213530	Test Receiver	Rohde & Schwarz	ESW44	103068	2024/02/22	12

**\*Hyphens for Last Calibration Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.**

**The expiration date of the calibration is the end of the expired month.**

**As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.**

**All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.**

#### Test item:

**RE: Radiated Emission**

**FT: Frequency Tolerance**

**BW: 20 dB bandwidth & 99 % Occupied bandwidth**